## Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
10767077	TANAKA ET AL.
Examiner	Art Unit
Zhao, Daquan	2621

	SEARCHED		
Class	Subclass	Date	Examiner
386	96,125-126	4/16/2008	dz

SEARCH NOTES		
Search Notes	Date	Examiner
USPAT; USPGPUG; USOCR; EPO; JPO; DERWENT; IBM_TDB	4	DZ

INTERFERENCE SEA	ARCH	
Subclass	Date	Examiner
		INTERFERENCE SEARCH Subclass Date

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